

## P-Channel 1.8-V (G-S) MOSFET

**SI1013L  
S-SI1013L**

### FEATURES

- TrenchFET® Power MOSFET: 1.8-V Rated
- Gate-Source ESD Protected: 2000 V
- High-Side Switching
- Low On-Resistance: 1.2 Ω
- Low Threshold: 0.8 V (typ)
- Fast Switching Speed: 14 ns
- S- Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

### BENEFITS

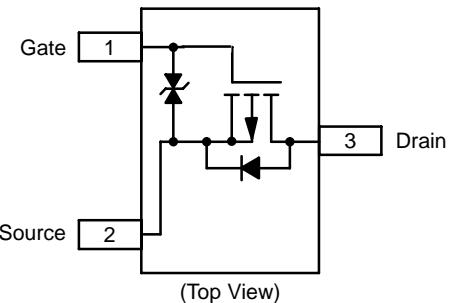
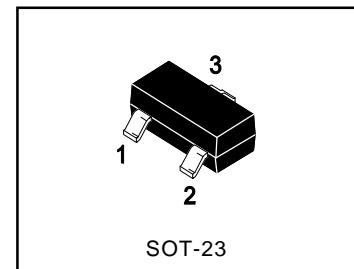
- Ease in Driving Switches
- Low Offset (Error) Voltage
- Low-Voltage Operation
- High-Speed Circuits
- Low Battery Voltage Operation

### APPLICATIONS

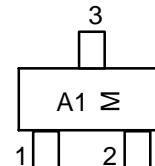
- Drivers: Relays, Solenoids, Lamps, Hammers, Displays, Memories
- Battery Operated Systems
- Power Supply Converter Circuits
- Load/Power Switching Cell Phones, Pagers

### ORDERING INFORMATION

| Device               | Marking | Shipping       |
|----------------------|---------|----------------|
| SI1013L<br>S-SI1013L | A1      | 3000/Tape&Reel |



### MARKING DIAGRAM



A1 = Specific Device Code

M = Month Code

### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

| Parameter   | Symbol         | 5 secs     | Steady State | Unit |  |
|---|----------------|------------|--------------|------|--|
| Drain-Source Voltage  | $V_{DS}$       | -20        | $\pm 6$      | V    |  |
| Gate-Source Voltage   | $V_{GS}$       |            |              |      |  |
| Continuous Drain Current ( $T_J = 150^\circ\text{C}$ ) <sup>b</sup> | $I_D$          | -400       | -350         | mA   |  |
|   |                | -300       | -275         |      |  |
| Pulsed Drain Current <sup>a</sup>                                   | $I_{DM}$       | -1000      |              |      |  |
| Continuous Source Current (diode conduction) <sup>b</sup>           | $I_S$          | -275       | -250         |      |  |
| Maximum Power Dissipation   | $P_D$          | 225        |              | mW   |  |
| Operating Junction and Storage Temperature Range                    | $T_J, T_{stg}$ | -55 to 150 |              | °C   |  |
| Gate-Source ESD Rating (HBM, Method 3015)                           | ESD            | 2000       |              | V    |  |

Notes

- d. Pulse width limited by maximum junction temperature.  
e. Surface Mounted on FR4 Board.



**SPECIFICATIONS ( $T_A = 25^\circ\text{C}$  UNLESS OTHERWISE NOTED)**

| Parameter                                     | Symbol              | Test Condition  | Min   | Typ     | Max     | Unit          |
|---|---------------------|---|-------|---------|---------|---------------|
| <b>Static</b>                                 |                     |   |       |         |         |               |
| Gate Threshold Voltage                        | $V_{GS(\text{th})}$ | $V_{DS} = V_{GS}, I_D = -250 \mu\text{A}$   | -0.45 |         | -1.3    | V             |
| Gate-Body Leakage                             | $I_{GSS}$           | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$  |       | $\pm 1$ | $\pm 2$ | $\mu\text{A}$ |
| Zero Gate Voltage Drain Current               | $I_{DSS}$           | $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$  |       | -0.3    | -100    | nA            |
|   |                     | $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}, T_J = 85^\circ\text{C}$  |       |         | -5      | $\mu\text{A}$ |
| On-State Drain Current <sup>a</sup>           | $I_{D(\text{on})}$  | $V_{DS} = -5 \text{ V}, V_{GS} = -4.5 \text{ V}$  | -700  |         |         | mA            |
| Drain-Source On-State Resistance <sup>a</sup> | $r_{DS(\text{on})}$ | $V_{GS} = -4.5 \text{ V}, I_D = -350 \text{ mA}$  |       | 0.8     | 1.2     | $\Omega$      |
|   |                     | $V_{GS} = -2.5 \text{ V}, I_D = -300 \text{ mA}$  |       | 1.2     | 1.6     |               |
|   |                     | $V_{GS} = -1.8 \text{ V}, I_D = -10 \text{ mA}$   |       | 1.8     | 2.7     |               |
| Forward Transconductance <sup>a</sup>         | $g_{fs}$            | $V_{DS} = -10 \text{ V}, I_D = -250 \text{ mA}$   |       | 0.4     |         | S             |
| Diode Forward Voltage <sup>a</sup>            | $V_{SD}$            | $I_S = -150 \text{ mA}, V_{GS} = 0 \text{ V}$   |       | -0.8    | -1.2    | V             |
| <b>Dynamic<sup>b</sup></b>                    |                     |   |       |         |         |               |
| Total Gate Charge                             | $Q_g$               | $V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -250 \text{ mA}$  |       | 1500    |         | pC            |
| Gate-Source Charge                            | $Q_{gs}$            |   |       | 150     |         |               |
| Gate-Drain Charge                             | $Q_{gd}$            |   |       | 450     |         |               |
| Turn-On Delay Time                            | $t_{d(\text{on})}$  | $V_{DD} = -10 \text{ V}, R_L = 47 \Omega$<br>$I_D \approx -200 \text{ mA}, V_{GEN} = -4.5 \text{ V}, R_G = 10 \Omega$ |       | 5       |         | ns            |
| Rise Time                                     | $t_r$               |   |       | 9       |         |               |
| Turn-Off Delay Time                           | $t_{d(\text{off})}$ |   |       | 35      |         |               |
| Fall Time                                     | $t_f$               |   |       | 11      |         |               |

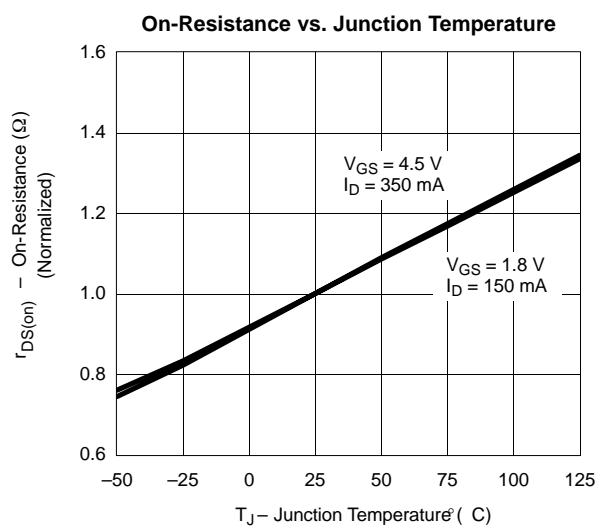
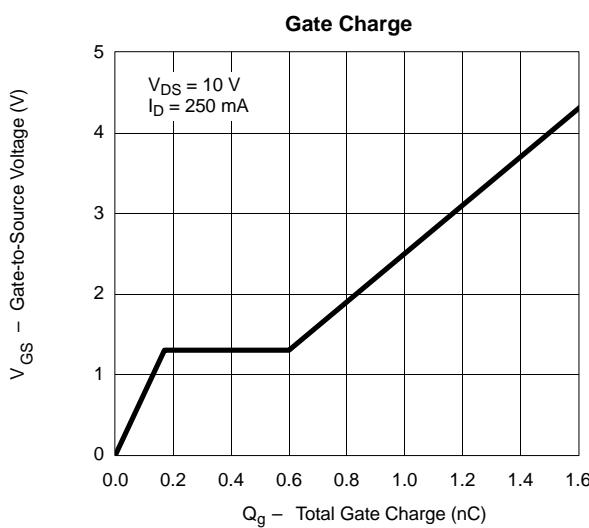
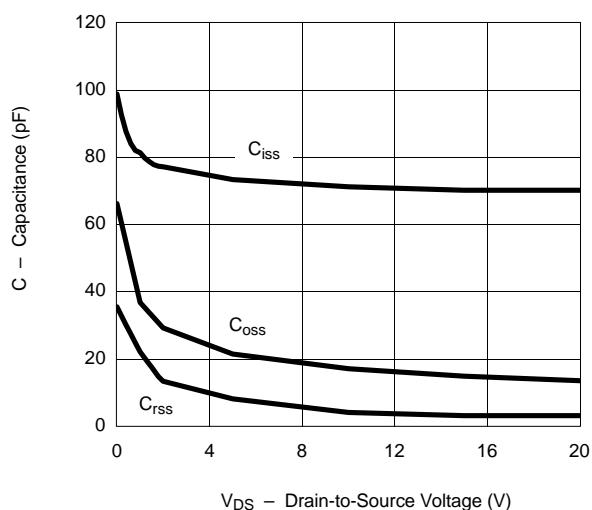
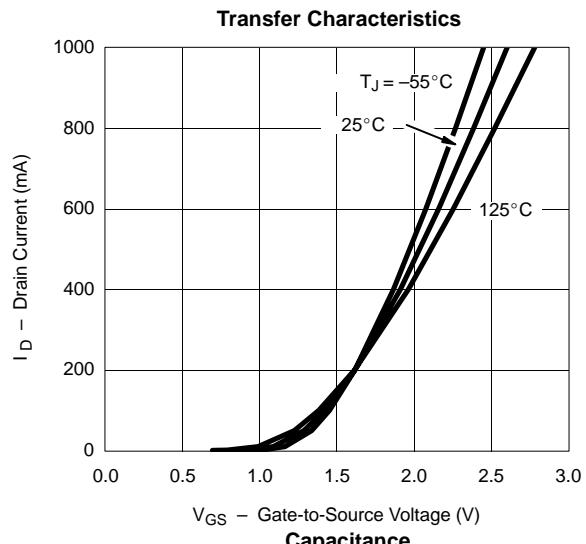
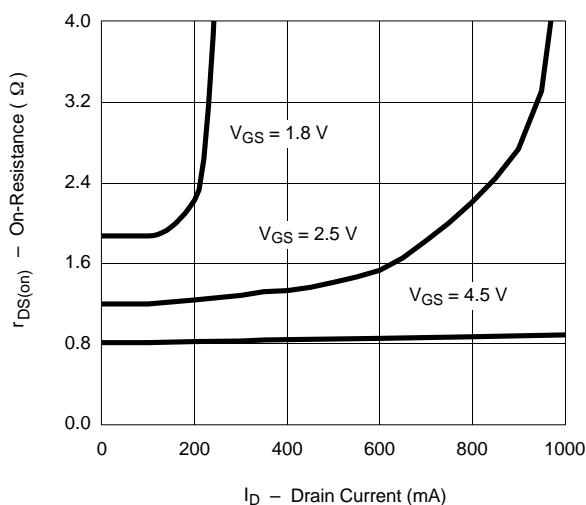
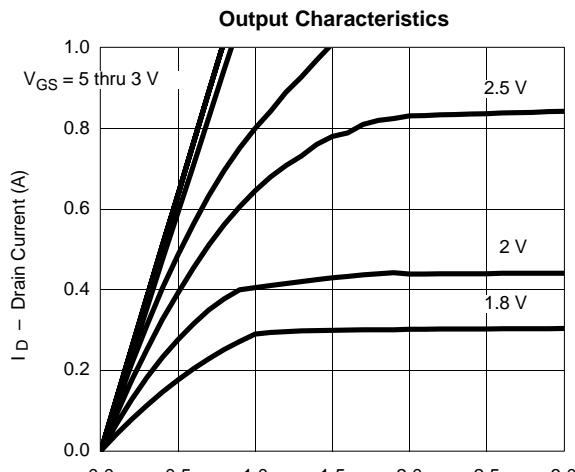
## Notes

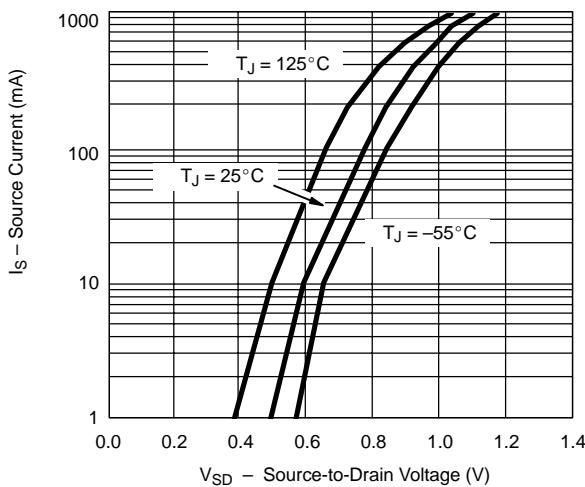
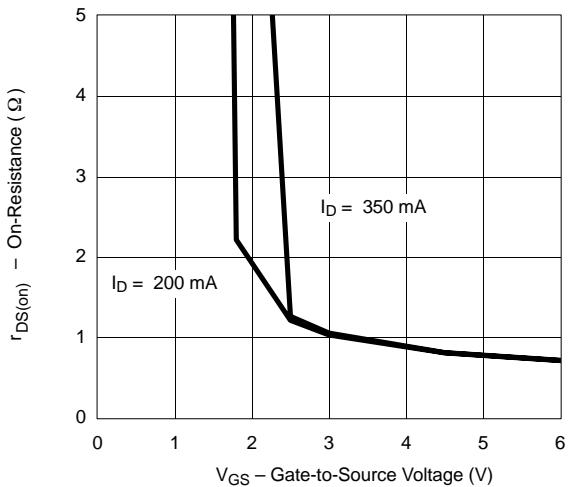
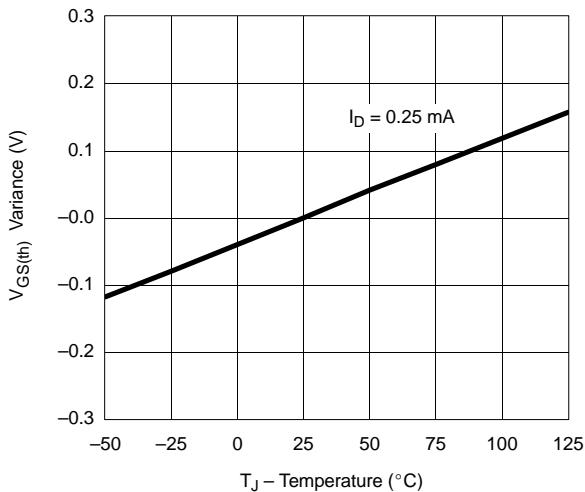
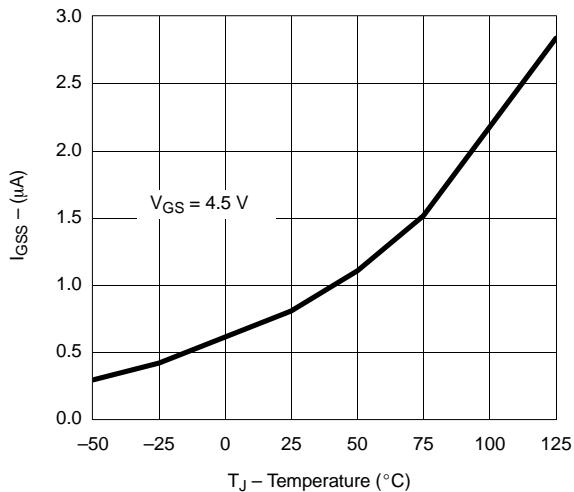
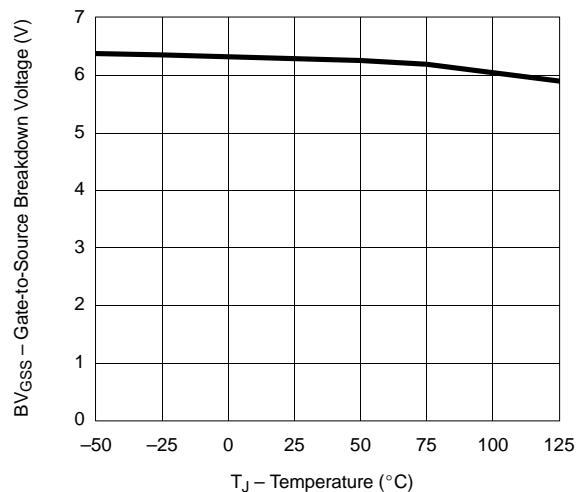
- a. Pulse test; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2\%$ .  
b. Guaranteed by design, not subject to production testing.



**TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$  UNLESS NOTED)**

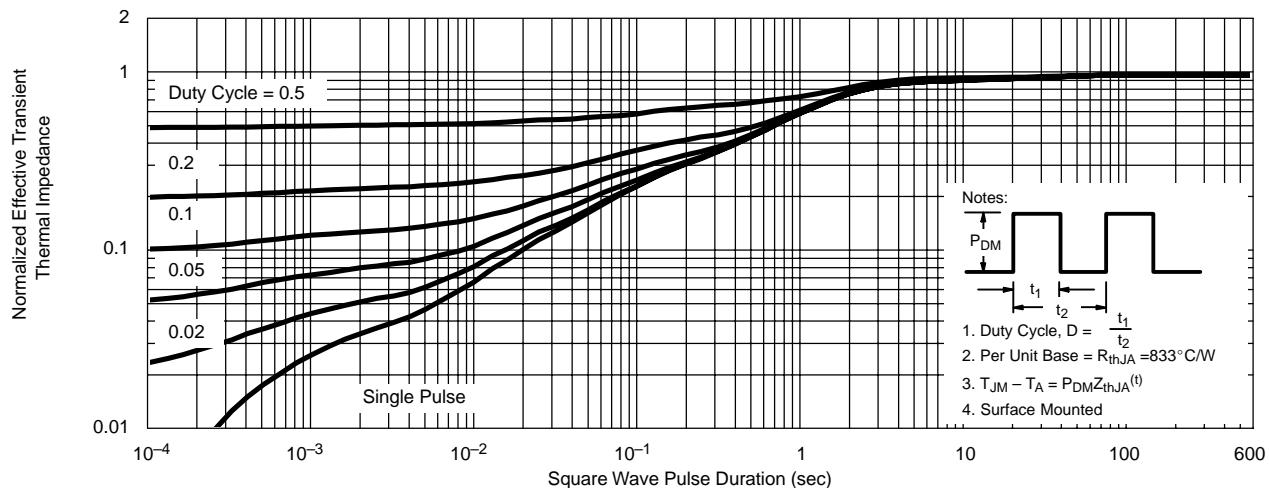
For the following graphs, p-channel negative polarities for all voltage and current values are represented as positive values.



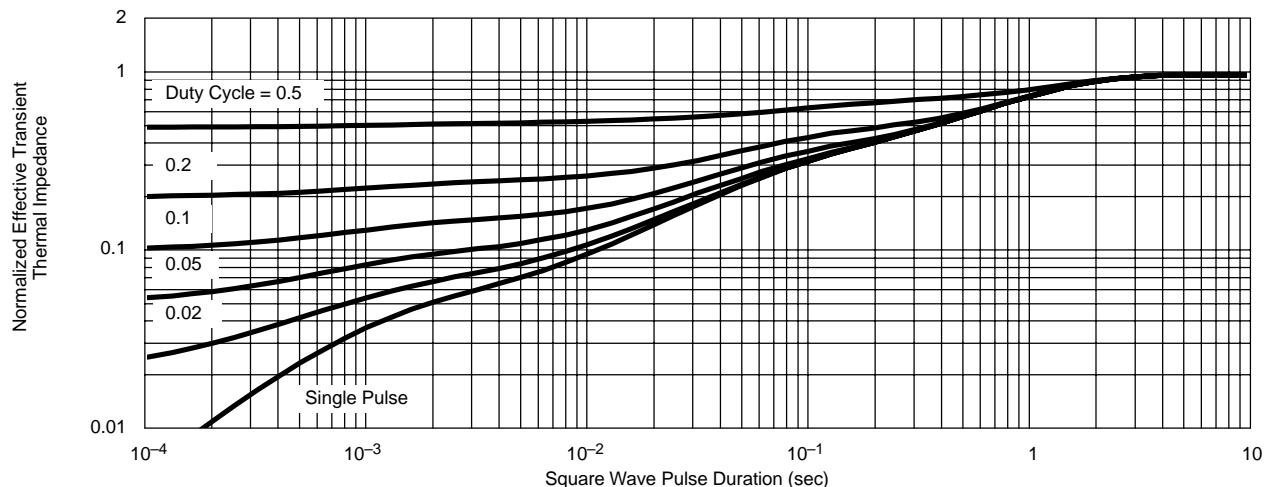
**TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$  UNLESS NOTED)**
**Source-Drain Diode Forward Voltage**

**On-Resistance vs. Gate-to-Source Voltage**

**Threshold Voltage Variance vs. Temperature**

 **$I_{GSS}$  vs. Temperature**

 **$BV_{GSS}$  vs. Temperature**


**TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$  UNLESS NOTED)**

Normalized Thermal Transient Impedance, Junction-to-Ambient (SC-75A)



Normalized Thermal Transient Impedance, Junction-to-Foot

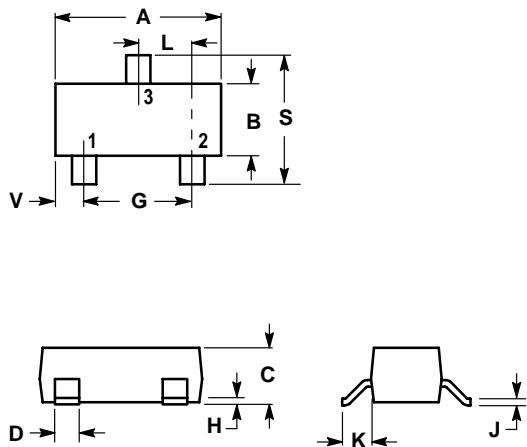


**SOT-23**

**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M,1982

2. CONTROLLING DIMENSION: INCH.



| DIM | INCHES |        | MILLIMETERS |       |
|-----|--------|--------|-------------|-------|
|     | MIN    | MAX    | MIN         | MAX   |
| A   | 0.1102 | 0.1197 | 2.80        | 3.04  |
| B   | 0.0472 | 0.0551 | 1.20        | 1.40  |
| C   | 0.0350 | 0.0440 | 0.89        | 1.11  |
| D   | 0.0150 | 0.0200 | 0.37        | 0.50  |
| G   | 0.0701 | 0.0807 | 1.78        | 2.04  |
| H   | 0.0005 | 0.0040 | 0.013       | 0.100 |
| J   | 0.0034 | 0.0070 | 0.085       | 0.177 |
| K   | 0.0140 | 0.0285 | 0.35        | 0.69  |
| L   | 0.0350 | 0.0401 | 0.89        | 1.02  |
| S   | 0.0830 | 0.1039 | 2.10        | 2.64  |
| V   | 0.0177 | 0.0236 | 0.45        | 0.60  |

